

Notice of References Cited

Application/Control No.

10/595,077

Applicant(s)/Patent Under
Reexamination
YAMAZAWA ET AL.

Examiner

Mary Lynn F. Theisen

Art Unit

1791

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0042641	03-2003	Abe et al.	264/40.1
*	B	US-7,435,367	10-2008	Oriakhi, Christopher	264/113
*	C	US-7,455,804	11-2008	Patel et al.	264/460
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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